

Search Notes

Application/Control No.

09/823,377

Examiner

Annan Q. Shang

Applicant(s)/Patent under
Reexamination

FERMAN ET AL

Art Unit

2617

SEARCHED

Class	Subclass	Date	Examiner
725	46-49,87- 105,116	10/26/2005	A.S
709	223,231-3	10/26/2005	A.S

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR